

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/670,087	09/24/2003	Dave Rotheroe	200300847-1	6327
22879	7590 02/08/200	96	EXAMINER	
	PACKARD COMP	SUN, XIUQIN		
	2400, 3404 E. HARM TUAL PROPERTY AI		ART UNIT	PAPER NUMBER
FORT COL	LINS, CO 80527-240	00	2863	

DATE MAILED: 02/08/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

				<u></u>
		Application No.	Applicant(s)	· · · · · ·
		10/670,087	ROTHEROE, DAVE	
C	Office Action Summary	Examiner	Art Unit	
		Xiuqin Sun	2863	
The Period for Re	MAILING DATE of this communication app ply	ears on the cover sheet with	the correspondence address	
WHICHEV - Extensions of after SIX (6) - If NO period - Failure to re Any reply re	ENED STATUTORY PERIOD FOR REPLY ER IS LONGER, FROM THE MAILING DA of time may be available under the provisions of 37 CFR 1.13 MONTHS from the mailing date of this communication. for reply is specified above, the maximum statutory period we ply within the set or extended period for reply will, by statute, believed by the Office later than three months after the mailing in term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICA 36(a). In no event, however, may a reply rill apply and will expire SIX (6) MONTHS cause the application to become ABANI	TION. be timely filed From the mailing date of this communication ONED (35 U.S.C. § 133).	
Status				
1)⊠ Res _l	oonsive to communication(s) filed on 19 De	ecember 2005.		
2a)⊠ This	action is FINAL. 2b) This	action is non-final.		
3)☐ Sinc	e this application is in condition for allowar	nce except for formal matters	, prosecution as to the merits	is
close	ed in accordance with the practice under E	x parte Quayle, 1935 C.D. 1	1, 453 O.G. 213.	
Disposition o	f Claims			
4)⊠ Clair	m(s) <u>11-19,27-30,34-41 and 45</u> is/are pend	ling in the application.		
•	of the above claim(s) is/are withdraw		; · · ·	
•	m(s) is/are allowed.	\$		
6)⊠ Clair	m(s) <u>11-19,27-30,34-41 and 45</u> is/are rejec			
7)☐ Clair	m(s) is/are objected to.		7 : 1 · · · · · ·	
8)∭ Clair	m(s) are subject to restriction and/or	r election requirement.		
Application P	apers			
	specification is objected to by the Examine	r.	. •	
,	drawing(s) filed on <u>24 September 2003</u> is/a		bjected to by the Examiner.	
	cant may not request that any objection to the			
Repl	acement drawing sheet(s) including the correct	ion is required if the drawing(s)	is objected to. See 37 CFR 1.121	(d).
11) The	oath or declaration is objected to by the Ex	aminer. Note the attached O	ffice Action or form PTO-152.	
Priority under	r 35 U.S.C. § 119			
12) Ackn	owledgment is made of a claim for foreign b) Some * c) None of:	priority under 35 U.S.C. § 1	19(a)-(d) or (f).	
1.	Certified copies of the priority documents	s have been received.		
2.	Certified copies of the priority documents	s have been received in App	lication No	
3.	Copies of the certified copies of the prior	ity documents have been re	ceived in this National Stage	
	application from the International Bureau	ı (PCT Rule 17.2(a)).		
* See th	ne attached detailed Office action for a list	of the certified copies not red	ceived.	
			•	
Attachmant/=1				
Attachment(s) 1) Notice of R	eferences Cited (PTO-892)	4) Interview Sum	nmary (PTO-413)	
2) Notice of D 3) Information	raftsperson's Patent Drawing Review (PTO-948) Disclosure Statement(s) (PTO-1449 or PTO/SB/08))/Mail Date	Paper No(s)/N	fail Date mal Patent Application (PTO-152)	
	,		:	

Art Unit: 2863

DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 11, 13, 16, 17, 27, 35 and 38 are rejected under 35 U.S.C. 103(a) as being unpatentable over Oliver et al. (U.S. Pub. No. 20030225876) in view of Swisher et al. (U.S. Pub. No. 20040015309) and Wolton et al. (U.S. Pub. No. 20040030741).

In regard to claims 11 and 17:

Oliver et al. teach a method of displaying measured parameters associated with each piece of equipment in an array of electronic equipment, comprising: retrieving data representing the measured parameters (Fig. 8; sections 0027 and 0054); mapping the measured parameters to color codes (Fig. 8; sections 0026 and 0038); displaying a graphic representation of the array of electronic equipment (Fig. 8; sections 0009, 0028, 0029); and in the graphic representation, representing each piece of electronic equipment in the array with the color mapped to a measured parameter associated with the piece of electronic equipment (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055). Oliver et al. further teach a computer readable storage medium storing instructions that, when executed on a programmed processor, carry out the method recited above (Figs. 2 and 5; sections 0030-0034 and 0042).

Art Unit: 2863

Oliver et al. do not mention explicitly: retrieving data representing the measured parameters from a database; said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack; displaying a three-dimensional graphic representation of the array of electronic equipment.

Swisher et al. disclose a method and system for modeling and analyzing a network infrastructure, and teach the step and means of: retrieving data representing the information to be displayed for data visual analysis from a database (sections 0042 and 0253); displaying a graphic representation of the array of electronic equipment (sections 0016, 0024 and 0036); wherein said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack (sections 0016, 0024 and 0036).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include GIS (geographical information system) features, as taught by Swisher et al., in the invention of Oliver et al. in order to allow a user to pinpoint spot any equipment to be monitored on the rack geographically (Swisher et al., Abstract).

Wolton et al. teach a method and apparatus for search, visual navigation, analysis and retrieval of information from networks, including the graphic representation

that comprises a three-dimensional graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the invention of Oliver et al. in order to provide a comprehensive and user-friendly graphical visualization method and system for automatically engaging certain search and data retrieval activities on behalf of the user and analyzing data collected from networks of electronic equipments (Wolton et al., Abstract; sections 0057-0059 and 0161).

In regard to claim 13 and 16:

Oliver et al. further includes: said method is carried out in a programmed processor (Figs. 2 and 5).

Oliver et al. in view of Swisher et al. do not mention explicitly: the view selected by the operator comprises one of a panned view, a rotated view, a tilted view, a moved view and a zoomed view of the three-dimensional graphic representation.

The teaching of Wolton et al. further includes: the view selected by the operator comprises one of a panned view, a rotated view, a tilted view, a moved view and a zoomed view of the three-dimensional graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the combination of Oliver et al. and Swisher et al. in order to provide a comprehensive and user-friendly data

visualization method and system for analyzing data information collected from networks of electronic equipments (Wolton et al., Abstract and sections 0057-0059).

In regard to claim 27:

Oliver et al. further teach a system that displays measured parameters associated with a plurality of pieces of equipment in an array of electronic equipment (see Abstract), comprising: a communication circuit that receives data representing the measured parameters from the plurality of pieces of equipment (Fig. 2); a computer programmed to carry out the functions of (Figs. 5 and 8): receiving the data that relates the measured parameters to the plurality of pieces of equipment (sections 0027 and 0054); mapping the measured parameters to color codes (sections 0026 and 0038); rendering a graphic representation of the array of electronic equipment (sections 0009, 0028, 0029, 0054 and 0055); and wherein, in the graphic representation, each piece of electronic equipment in the array is represented with the color mapped to a measured parameter associated with the piece of electronic equipment (sections 0009, 0028, 0029, 0054 and 0055).

Oliver et al. do not mention explicitly: said graphic representation is a three-dimensional graphic representation; said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack.

Swisher et al. disclose a method and system for modeling and analyzing a network infrastructure, and teach the step and means of: displaying a graphic

representation of the array of electronic equipment (sections 0016, 0024 and 0036); wherein said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack (sections 0016, 0024 and 0036).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include GIS (geographical information system) features, as taught by Swisher et al., in the invention of Oliver et al. in order to allow a user to pinpoint spot any equipment to be monitored on the rack geographically (Swisher et al., Abstract).

Wolton et al. disclose a method and computer software application for graphical visualization of network information, and teach displaying a three-dimensional graphic representation of any data regarding the network to be visualized (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the combination of Oliver et al. and Swisher et al. in order to provide a comprehensive and user-friendly graphical visualization method and system for analyzing data information collected from networks of electronic equipments (Wolton et al., Abstract and sections 0057-0059).

In regard to claim 35:

Oliver et al. teach an apparatus of monitoring measured parameters associated with each piece of equipment in an array of electronic equipment, comprising: means for

Art Unit: 2863

retrieving data representing the measured parameters (Fig. 8; sections 0027 and 0054); means for mapping the measured parameters to color codes (Fig. 8; sections 0026 and 0038); means for presenting a graphic representation of the array of electronic equipment to a display (Fig. 8; sections 0009, 0028, 0029); and in the graphic representation, representing each piece of electronic equipment in the array with the color mapped to a measured parameter associated with the piece of electronic equipment (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055).

Oliver et al. do not mention explicitly: said graphic representation is a three-dimensional graphic representation; said graphic representation further depicting the equipment rack with a three-dimensional graphic representation of each piece of equipment situated in a position of said graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack.

Swisher et al. disclose a method and system for modeling and analyzing a network infrastructure, and teach the means of: displaying a graphic representation of the array of electronic equipment (sections 0016, 0024 and 0036); wherein said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack (sections 0016, 0024 and 0036).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include GIS (geographical information system) features, as taught by Swisher et al., in the invention of Oliver et al. in order to allow a user to

pinpoint spot any equipment to be monitored on the rack geographically (Swisher et al., Abstract).

Wolton et al. disclose a method and computer software application for graphical visualization of network information, and teach displaying a three-dimensional graphic representation of any data regarding the network to be visualized (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the combination of Oliver et al. and Swisher et al. in order to provide a comprehensive and user-friendly graphical visualization method and system for analyzing data information collected from networks of electronic equipments (Wolton et al., Abstract and sections 0057-0059).

In regard to claims 29, 30 and 37:

Oliver et al. further includes: receiving an input from a user interface that indicates a change in view has been selected by an operator (sections 0028 and 0029); wherein the computer program includes graphics rendering code that renders a new graphic representation of the array of electronic equipment to change to the view selected by the operator (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055); and in the graphic representation, representing each piece of electronic equipment in the array with the color mapped to the measured parameter (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055).

Oliver et al. in view of Swisher et al. do not mention explicitly: said graphic representation is a three-dimensional graphic representation; said view selected by the

Art Unit: 2863

operator comprises one of a panned view and a zoomed view of the graphic representation.

The teaching of Wolton et al. includes: the view selected by the operator comprises one of a panned view and a zoomed view of the graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589); the graphic representation comprises a three-dimensional graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the combination of Oliver et al. and Swisher et al. in order to provide a comprehensive and user-friendly data visualization method and system for analyzing data information collected from networks of electronic equipments (Wolton et al., Abstract and sections 0057-0059).

In regard to claim 38:

Oliver et al. teach a method of monitoring a predetermined parameter in each of a plurality of electrical devices located in a locality (see Abstract), comprising: generating a user graphical display of graphical representations of the devices as positioned in the locality (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055); and coloring each of the graphical representations of the devices with a predetermined color corresponding to a currently measured value of the predetermined parameter for the corresponding device (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055).

Oliver et al. do not mention explicitly: said graphical representation is a threedimensional graphical representation; said graphic representation depicting the

0000

Art Unit: 2863

equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack.

Swisher et al. disclose a method and system for modeling and analyzing a network infrastructure, and teach: a graphic representation of the array of electronic equipment (sections 0016, 0024 and 0036); wherein said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack (sections 0016, 0024 and 0036).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include GIS (geographical information system) features, as taught by Swisher et al., in the invention of Oliver et al. in order to allow a user to pinpoint spot any equipment to be monitored on the rack geographically (Swisher et al., Abstract).

Wolton et al. teach a user graphical display of three-dimensional graphical representations of a system for monitoring an array of electronic devices (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the invention of Oliver et al. in order to provide a comprehensive and user-friendly data visualization method and

system for analyzing data information collected from networks of electronic equipments (Wolton et al., Abstract and sections 0057-0059).

3. Claims 12, 15, 18, 28, 36, and 39-41 are rejected under 35 U.S.C. 103(a) as being unpatentable over Oliver et al. in view of Swisher et al. and Wolton et al., as applied to claims 11, 27, 35 and 38 above, and further in view of Shimada et al. (U.S. Pat. No. 6757580).

In regard to claims 12, 15 and 39-41:

Oliver et al., Swisher et al. and Wolton et al. teach the method including the subject matter discussed above. The teaching of Oliver et al. further include: receiving an input from a user interface that indicates a change in view has been selected by an operator (sections 0028 and 0029), and re-generating the graphic display to change to the view selected by the operator (sections 0009, 0028, 0029, 0054 and 0055). The teaching of Wolton et al. includes: a graphic representation comprises a three-dimensional graphic representation, and wherein the view selected by the operator comprises one of a panned view, a rotated view, a tilted view, a moved view and a zoomed view of the graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

Oliver et al. in view of Swisher et al. and Wolton et al. do not mention: receiving updated parameters from the electronic equipment and storing the updated parameters in the database on a periodic basis; determining that a database update has occurred; and retrieving updated measured parameters from the database for re-displaying.

Art Unit: 2863

Shimada et al. teach an electronic device monitoring system, including: receiving updated parameters from the electronic equipment and storing the updated parameters in the database on a periodic basis (col. 7, lines 36-39; col. 7, lines 62-67; col. 8, lines 1-16 and col. 10, lines 3-19); determining that a database update has occurred (col. 14, lines 3-13 and lines 18-24); and retrieving updated measured parameters from the database for graphical display (col. 19, lines 66-67 and col. 20, lines 1-21).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Shimada et al. in the combination of Oliver, Swisher and Wolton in order to provide a mechanism through which the newest data information collected from the monitoring system can be displayed and analyzed (Shimada et al., col. 19, lines 66-67; col. 20, lines 1-21 and col. 14, lines 3-13 and lines 18-24).

In regard to claim 18:

Oliver et al. teach a method of displaying measured parameters associated with each piece of equipment in an array of electronic equipment, comprising: retrieving data representing the measured parameters (Fig. 8; sections 0027 and 0054); mapping the measured parameters to color codes (Fig. 8; sections 0026 and 0038); displaying a graphic representation of the array of electronic equipment (Fig. 8; sections 0009, 0028, 0029); and in the graphic representation, representing each piece of electronic equipment in the array with the color mapped to a measured parameter associated with the piece of electronic equipment (Fig. 8; sections 0009, 0028, 0029, 0054 and 0055).

Art Unit: 2863

Oliver et al. do not mention explicitly: retrieving data representing the measured parameters from a database; displaying a three-dimensional graphic representation of the array of electronic equipment; determining that a database update has occurred; and retrieving updated measured parameters from the database for re-displaying; wherein each graphic representation further depicts the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack.

Swisher et al. disclose a method and system for modeling and analyzing a network infrastructure, and teach the step and means of: retrieving data representing the information to be displayed for data visual analysis from a database (sections 0042 and 0253); displaying a graphic representation of the array of electronic equipment (sections 0016, 0024 and 0036); wherein said graphic representation further depicting the equipment rack with a graphic representation of each piece of equipment situated in a position of the graphic representation of the equipment rack corresponding to the physical location of the equipment in the equipment rack (sections 0016, 0024 and 0036).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include GIS (geographical information system) features, as taught by Swisher et al., in the invention of Oliver et al. in order to allow a user to pinpoint spot any equipment to be monitored on the rack geographically (Swisher et al., Abstract).

Wolton et al. teach a method and apparatus for search, visual navigation, analysis and retrieval of information from networks, including: the graphic representation comprises a three-dimensional graphic representation (sections 0055, 0057-0059, 0081, 0153, 0290, 0413, 0586 and 0589).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Wolton et al. in the invention of Oliver et al. in order to provide a comprehensive and user-friendly data visualization method and system for automatically engaging certain search and data retrieval activities on behalf of the user and analyzing data collected from networks of electronic equipments (Wolton et al., Abstract; sections 0057-0059 and 0161).

Shimada et al. teach an electronic device monitoring system, including: storing monitored data in a database (col. 7, lines 36-39; col. 7, lines 62-67; col. 8, lines 1-16 and col. 10, lines 3-19); determining that a database update has occurred (col. 14, lines 3-13 and lines 18-24); and retrieving updated measured parameters from the database for graphical display (col. 19, lines 66-67 and col. 20, lines 1-21).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Shimada et al. in the combination of Oliver, Swisher and Wolton in order to provide a mechanism through which the newest data information collected from the monitoring system can be displayed and analyzed (Shimada et al., col. 19, lines 66-67; col. 20, lines 1-21 and col. 14, lines 3-13 and lines 18-24).

In regard to claims 28 and 36:

Art Unit: 2863

Oliver et al., Swisher et al. and Wolton et al. teach the method including the subject matter discussed above. The teaching of Oliver et al. further include: receiving an input from a user interface that indicates a change in view has been selected by an operator (sections 0028 and 0029), and re-generating the graphic display to change to the view selected by the operator (sections 0009, 0028, 0029, 0054 and 0055).

Oliver et al. in view of Swisher et al. and Wolton et al. do not mention: receiving updated parameters from the electronic equipment and storing the updated parameters in the database on a periodic basis; determining that a database update has occurred; and retrieving updated measured parameters from the database for re-displaying.

Shimada et al. teach an electronic device monitoring system, including: receiving updated parameters from the electronic equipment and storing the updated parameters in the database on a periodic basis (col. 7, lines 36-39; col. 7, lines 62-67; col. 8, lines 1-16 and col. 10, lines 3-19); determining that a database update has occurred (col. 14, lines 3-13 and lines 18-24); and retrieving updated measured parameters from the database for graphical display (col. 19, lines 66-67 and col. 20, lines 1-21).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Shimada et al. in the combination of Oliver, Swisher and Wolton et al. in order to provide a mechanism through which the newest data information collected from the monitoring system can be displayed and analyzed (Shimada et al., col. 19, lines 66-67; col. 20, lines 1-21 and col. 14, lines 3-13 and lines 18-24).

Art Unit: 2863

4. Claim 14, 19, 34 and 45 are rejected under 35 U.S.C. 103(a) as being unpatentable over Oliver et al. in view of Swisher et al. and Wolton et al., as applied to claims 11, 18, 27 and 38 above, and further in view of Duffy et al. (U.S. Pub. No. 20020171985).

In regard to claims 14 and 45

Oliver et al., Swisher et al. and Wolton et al. teach the method including the subject matter discussed above. The combination of Oliver, Swisher and Wolton does not mention explicitly: the measured parameter comprises one of temperature, power, current and voltage.

Duffy et al. teach a system, device and method for monitoring and managing microelectronic device (see Abstract), including: measuring parameters such as temperature, power, current and voltage (sections 0065 and 0083).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Duffy et al. in the combination of Oliver, Swisher and Wolton in order to provide a method and system that is capable of monitoring power-supply induced thermal anomalies of electronic devices (Duffy et al., sections 0065 and 0083).

In regard to claim 19:

Oliver et al., Swisher et al., Wolton et al. and Shimada et al. teach the method including the subject matter discussed above. The combination of Oliver, Swisher, Wolton and Shimada does not mention explicitly: the measured parameter comprises one of temperature, power, current and voltage.

Duffy et al. teach a system, device and method for monitoring and managing microelectronic device (see Abstract), including: measuring parameters such as temperature, power, current and voltage (sections 0065 and 0083).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Duffy et al. in the combination of Oliver, Swisher, Wolton and Shimada in order to provide a method and system that is capable of monitoring power-supply induced thermal anomalies of electronic devices (Duffy et al., sections 0065 and 0083).

In regard to claim 34:

Oliver et al. and Swisher et al. teach the method including the subject matter discussed above. The combination of Oliver, Swisher and Wolton does not mention explicitly: the measured parameter comprises one of temperature, power, current and voltage.

Duffy et al. teach a system, device and method for monitoring and managing microelectronic device (see Abstract), including: measuring parameters such as temperature, power, current and voltage (sections 0065 and 0083).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Duffy et al. in the combination of Oliver, Swisher and Wolton in order to provide a method and system that is capable of monitoring power-supply induced thermal anomalies of electronic devices (Duffy et al., sections 0065 and 0083).

Art Unit: 2863

Conclusion

5. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Response to Arguments

6. Applicant's arguments received 12/19/05 with respect to claims 11-19, 27-30, 34-41 and 45 have been have been fully considered but they are not persuasive.

In response to applicant's arguments against the references individually, one cannot show nonobviousness by attacking references individually where the rejections are based on combinations of references. See *In re Keller*, 642 F.2d 413, 208 USPQ 871 (CCPA 1981); *In re Merck & Co.*, 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986). In this case, the examiner considers that Oliver et al. in view of Swisher et al. are not clear about a three-dimensional view of said graphical representation. The combination of Oliver et al. in view of Swisher et al. with Wolton's teaching of three-

Art Unit: 2863

dimensional representation of the data being displayed reads on the claims. The combination of the references is, therefore, proper. The rejections stand.

Contact Information

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Xiuqin Sun whose telephone number is (571)272-2280. The examiner can normally be reached on 6:30am-4:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571)272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

s X S Clid

PRIMARY EXAMINER

Xiuqin Sun Examiner Art Unit 2863